Se	arcn	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/777,076	STERN ET AL.	
Examiner	Art Unit	
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Thien M. Le	2876	

	SEAR	CHED	
Class	Subclass	Date	Examiner
235	462.01- 462.47		
	472.01		
	472.02		
	472.03	,	
	454		
	455		
	470	4/26/2006	LTM

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	<u></u>		

	DATE	EXMR
EAST (conducted 4/28/2006, refreshed 5/1/2006)	5/1/2006	LTM.
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